

<b>Notice of References Cited</b>	Application/Control No. 10/575,472	Applicant(s)/Patent Under Reexamination CANSELL ET AL.	
	Examiner Noah S. Wiese	Art Unit 1709	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	Chen, R et al. Structure, sintering behavior and dielectric properties of silica-coated BaTiO <sub>3</sub> . Materials Letters. North Holland Publishing Company; Amsterdam, NL. vol 54, no. 4, June 2002. pg 314-317.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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